

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/849,783	NEAL ET AL.	
Examiner	Art Unit	
Beth Van Doren	3623	

SEARCHED						
Class	Subclass	Date	Examiner			
		<u> </u>				
	<u> </u>					

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
	<u> </u>					
	<u></u>					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Updated East (US, JPAB, Derwent, EPAB, IBM_TD, PGPub)	11/30/2005				
considered other applications filed by same inventors	11/30/05				